## Notice of References Cited Application/Control No. 10/763,603 Applicant(s)/Patent Under Reexamination NAKAMURA ET AL. Examiner Zhuo H Li Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,108,748	08-2000	Ofek et al.	711/112
	В	US-6,173,377	01-2001	Yanai et al.	711/162
	С	US-6,684,306	01-2004	Nagasawa et al.	711/162
	D	US-6,732,244	05-2004	Ashton et al.	711/162
	Ε	US-6,088,815	07-2000	West et al.	714/15
	F	US-6,499,112	12-2002	Milillo et al.	714/6
	G	US-5,701,436	12-1997	Nagashima et al.	711/162
	I	US-6,578,120	06-2003	Crockett et al.	711/162
	_	US-5,692,155	11-1997	Iskiyan et al.	711/162
	7	US-			
	κ	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т	*****				

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.